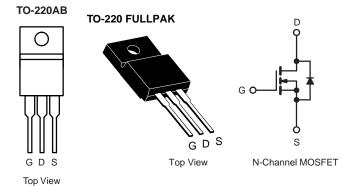


# N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)	
60	0.027 at V <sub>GS</sub> = 10 V	55		
	0.029 at V <sub>GS</sub> = 6 V	55	27.5 nC	
	0.030 at V <sub>GS</sub> = 4.5 V	50		



#### **FEATURES**

- DT-Trench Power MOSFET
- 100 %  $\rm R_{\rm g}$  and UIS Tested
- Low Q<sub>g</sub> for High Efficiency



#### **APPLICATIONS**

- · Primary Side Switch
- POL
- Synchronous Rectifier
- DC/DC Converter
- · Amusement System
- Industrial
- LED Backlighting

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$	I <sub>D</sub>	55 <sup>a</sup> 55 <sup>a</sup> 35.8 <sup>b, c</sup> 28.6 <sup>b, c</sup>		
Pulsed Drain Current (60 µs Pulse Width)		I <sub>DM</sub>	350	A	
Continuous Source-Drain Diode Current	$T_C = 25 ^{\circ}C$ $T_A = 25 ^{\circ}C$	I <sub>S</sub>	55 <sup>a</sup> 5.6 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	40		
Single Pulse Avalanche Energy		E <sub>AS</sub>	80	mJ	
Maximum Power Dissipation	$T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$	P <sub>D</sub>	104 66.6 6.25 <sup>b, c</sup> 4 <sup>b, c</sup>	W	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature		260			

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient	t ≤ 10 s	R <sub>thJA</sub>	15	20	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	0.9	1.2	] 0,77	

#### Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	60			V	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 6		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zama Oata Vallana Busin Oussa :	I <sub>DSS</sub>	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V			1	μΑ	
Zero Gate Voltage Drain Current		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
	) /	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.027	0.030		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 6 \text{ V}, I_D = 20 \text{ A}$		0.029	0.032	Ω	
		$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.030	0.034	1	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A		82		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			1475		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		305			
Reverse Transfer Capacitance	C <sub>rss</sub>			77			
Total Cata Channa	Q <sub>g</sub> -	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		63.5	96	nC	
Total Gate Charge		$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		27.5	42		
Gate-Source Charge				12			
Gate-Drain Charge	$Q_{gd}$			5.9			
Gate Resistance	$R_{g}$	f = 1 MHz	0.4	1.2	2.4	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			14	28	ne	
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V, } R_L = 3 \Omega$ $I_D \cong 10 \text{ A, } V_{GEN} = 10 \text{ V, } R_g = 1 \Omega$		11	22		
Turn-Off Delay Time	t <sub>d(off)</sub>			33	60		
Fall Time	t <sub>f</sub>			11	22		
Turn-On Delay Time	t <sub>d(on)</sub>			47	90	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_L = 3 \Omega$		97	180		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		32	60		
Fall Time	t <sub>f</sub>			13	26		
<b>Drain-Source Body Diode Characteristi</b>	cs						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			60	A	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				100		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A		0.73	1.1	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			79	120	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			88	135	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		32		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			47			

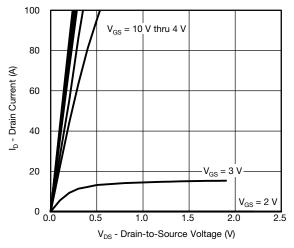
#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

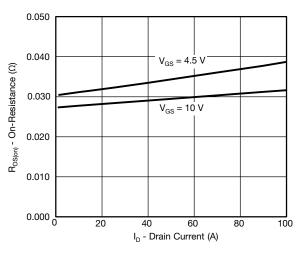
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

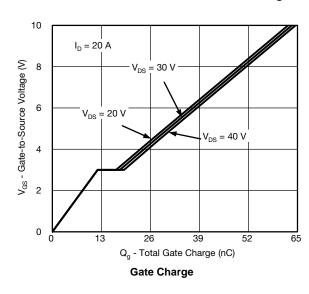
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

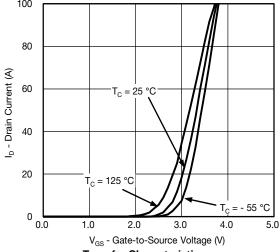


### **Output Characteristics**

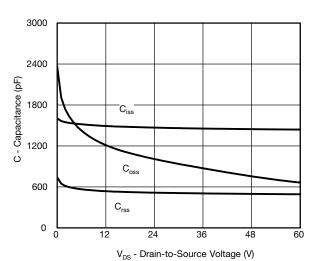


On-Resistance vs. Drain Current and Gate Voltage

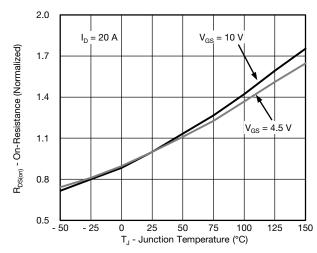




Transfer Characteristics

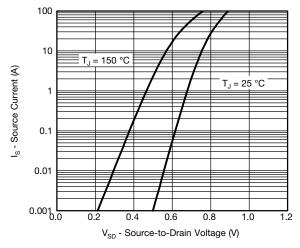


Capacitance

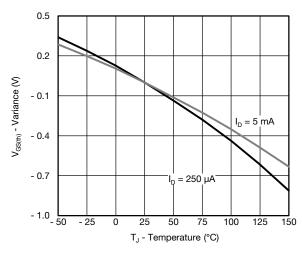


On-Resistance vs. Junction Temperature

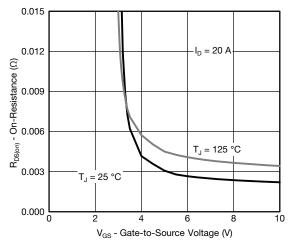
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



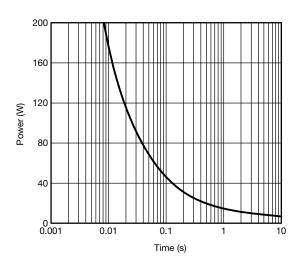
#### Source-Drain Diode Forward Voltage



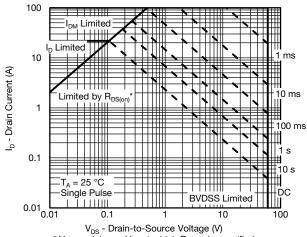
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage



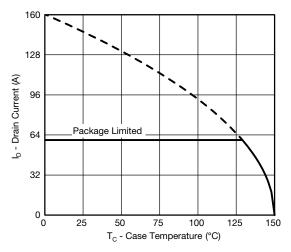
Single Pulse Power, Junction-to-Ambient



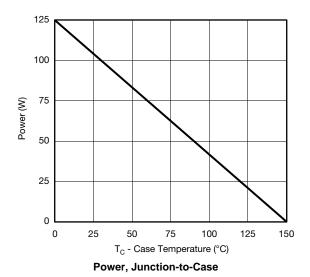
 $\rm V_{DS}$  - Drain-to-Source Voltage (V)  $^*$   $\rm V_{GS}$  > minimum  $\rm V_{GS}$  at which  $\rm R_{DS(on)}$  is specified

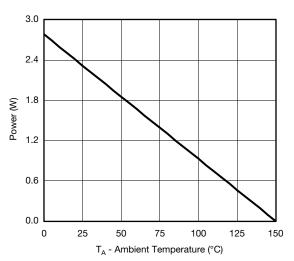
Safe Operating Area, Junction-to-Ambient

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### **Current Derating\***



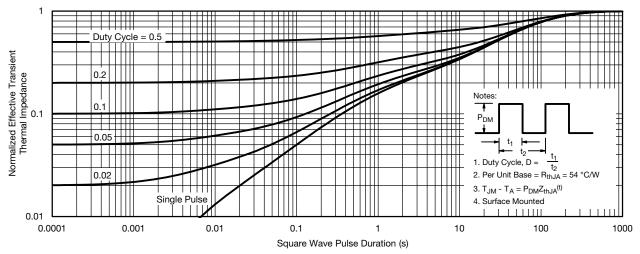


Power, Junction-to-Ambient

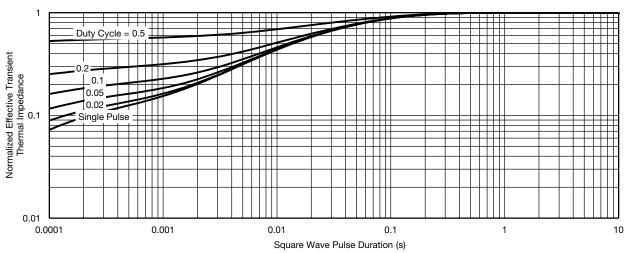
 $<sup>^*</sup>$  The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case





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